

Notice of References Cited	Application/Control No. 10/040,627		Applicant(s)/Patent Under Reexamination NAKAMURA ET AL.	
	Examiner Tamai IE Karl		Art Unit 2834	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-RE37,967 E	01-2003	Nakamura et al.	310/90
*	B	US-4,517,466	05-1985	Ogawa, Hitoshi	290/36R
	C	US-			
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	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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